DATA SHEET



# NP84N04CHE, NP84N04DHE, NP84N04EHE

## SWITCHING **N-CHANNEL POWER MOS FET INDUSTRIAL USE**

### DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

### **FEATURES**

- Channel temperature 175 degree rated
- Super low on-state resistance  $R_{DS(on)} = 5.2 \text{ m}\Omega \text{ MAX.} (V_{GS} = 10 \text{ V}, \text{ ID} = 42 \text{ A})$ • Low Ciss : Ciss = 4410 pF TYP.
- Built-in gate protection diode

### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	40	
VDSS	40	V
Vgss	±20	V
D(DC)	±84	А
D(pulse)	±336	А
Р⊤	1.8	W
Ρτ	200	W
las	84 / 61 / 22	А
Eas	70 / 372 / 484	mJ
Tch	175	°C
Tstg	-55 to +175	°C
	ID(DC) ID(puise) PT PT IAS EAS Tch	VGSS     ±20       ID(DC)     ±84       ID(pulse)     ±336       PT     1.8       PT     200       IAS     84 / 61 / 22       EAS     70 / 372 / 484       Tch     175

### Notes 1. Calculated constant current according to MAX. allowable channel temperature.

**2.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1 %

**3.** Starting  $T_{ch} = 25^{\circ}C$ ,  $R_G = 25 \Omega$ ,  $V_{GS} = 20 V \rightarrow 0 V$  (see Figure 4.)

### THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	0.75	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

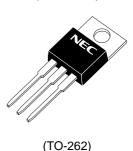
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The mark ★ shows major revised points.

**ORDERING INFORMATION** 

PART NUMBER	PACKAGE
NP84N04CHE	TO-220AB
NP84N04DHE	TO-262
NP84N04EHE	TO-263



(TO-220AB)





(TO-263)

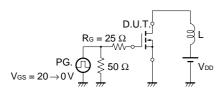


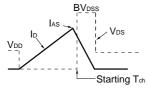
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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 42 A		4.6	5.2	mΩ
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	2.0	3.0	4.0	V
Forward Transfer Admittance	yfs	Vds = 10 V, Id = 42 A	23	47		s
Drain Leakage Current	loss	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			10	μA
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Input Capacitance	Ciss	V <sub>DS</sub> = 25 V		4410	6620	pF
Output Capacitance	Coss	Vgs = 0 V		950	1430	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		490	890	pF
Turn-on Delay Time	td(on)	ID = 42 A		36	79	ns
Rise Time	tr	$V_{GS(on)} = 10 V$		25	62	ns
Turn-off Delay Time	td(off)	$V_{DD} = 20 V$		77	150	ns
Fall Time	tr	$R_G = 1 \Omega$		28	69	ns
Total Gate Charge	QG	ID = 84 A		87	130	nC
Gate to Source Charge	QGS	$V_{DD} = 32 V$		20		nC
Gate to Drain Charge	Qgd	Vgs = 10 V		32		nC
Body Diode Forward Voltage	VF(S-D)	IF = 84 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 84 A, VGS = 0 V		49		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		60		nC

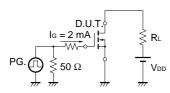
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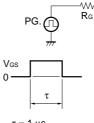
### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**





### **TEST CIRCUIT 3 GATE CHARGE**

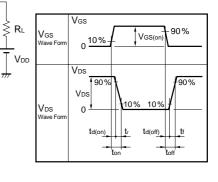




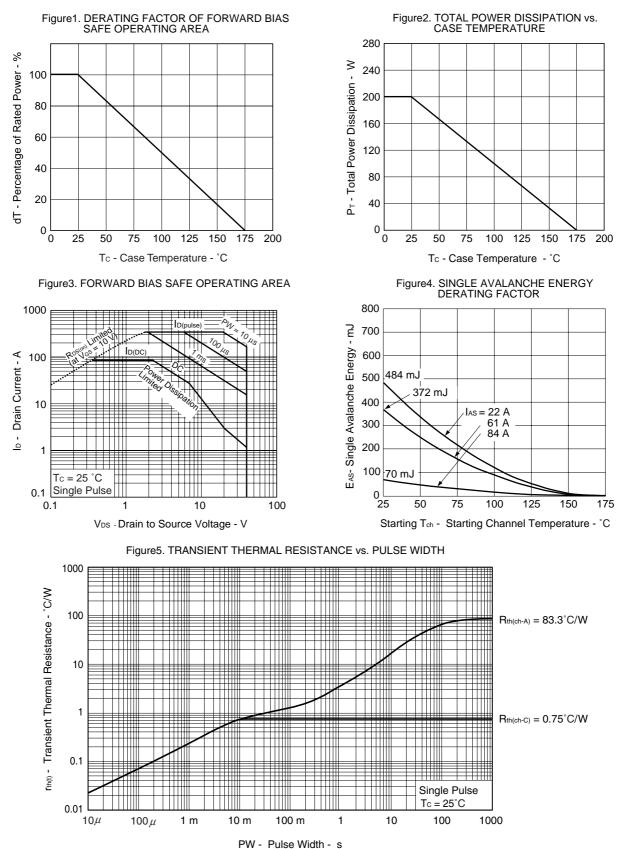
**TEST CIRCUIT 2 SWITCHING TIME** 

D.U.T.

 $\begin{array}{l} \tau = 1 \; \mu s \\ \text{Duty Cycle} \leq 1 \; \% \end{array}$ 



### TYPICAL CHARACTERISTICS ( $T_A = 25^{\circ}C$ )



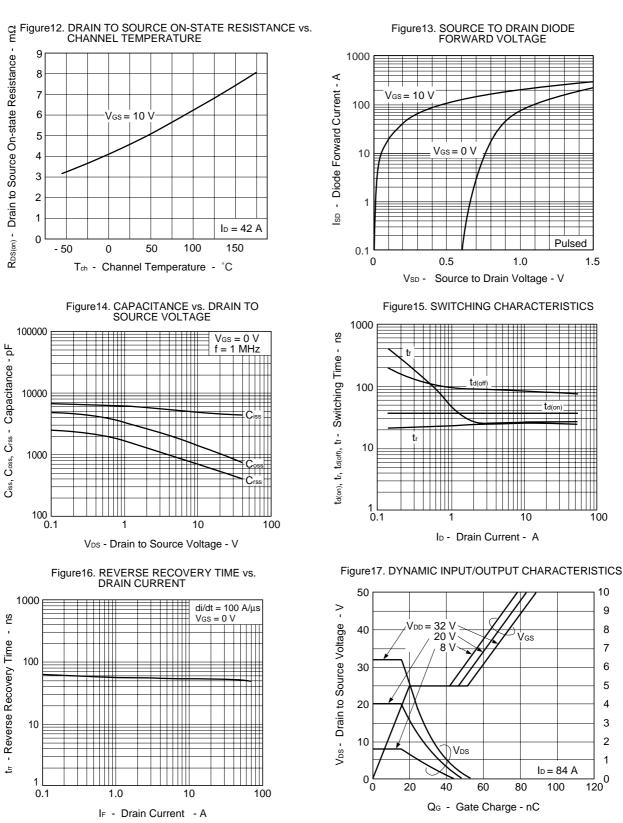
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Figure7. DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE Figure6. FORWARD TRANSFER CHARACTERISTICS 1000 Pulsed 400 Pulsed 320 ∢ 100 ∢ Drain Current -Drain Current - $V_{GS} = 10 V$ -55°C  $T_A =$ 240 25°C 10 75°C 150°C 160 175°C -<u>\_</u> 1 80 0 <mark>⊾</mark> 0.1 1 2 3 4 5 6 7 2 3 4 VDS - Drain to Source Voltage - V Vgs - Gate to Source Voltage - V Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE RDS(on) - Drain to Source On-state Resistance -  $m\Omega$ ς Υ 100 20 VDS=10V Pulsed Pulsed yts | - Forward Transfer Admittance 10 TA = 175°C 75°C 25°C 10 1 55°C 1111 ID = 42 A 0.1 0.01 0 0.01 0.1 1 10 100 0 5 10 15 20 ID - Drain Current - A VGS - Gate to Source Voltage - V Figure10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT Figure11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE  $R_{DS(on)}$  - Drain to Source On-state Resistance - m $\Omega$ >  $V_{DS} = V_{GS}$  $I_D = 250 \ \mu A$ Threshold Voltage Pulsed 15 4.0 3.0 10 Π to Source 2.0 Vgs = 10 V 5 Gate t 1.0 . V<sub>GS(th)</sub> 0 0 1000 -50 50 100 100 0 150 1 10 ID - Drain Current - A Tch - Channel Temperature - °C

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Pulsed

100

10

9 >

8

7

6

5

4

2

\_\_\_\_\_0 120

ID = 84 A

100

Source Voltage -

Gate to 3

V<sub>GS</sub> 1

td(on)

1.5

1.0

10

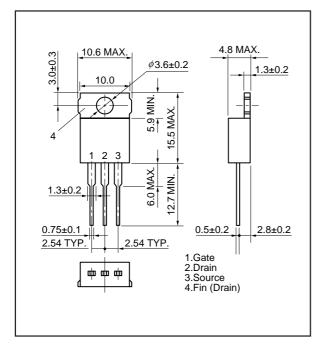
Vgs

80

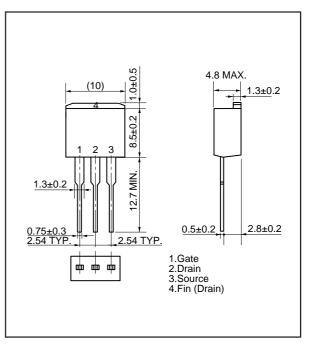
60

### PACKAGE DRAWINGS (Unit: mm)

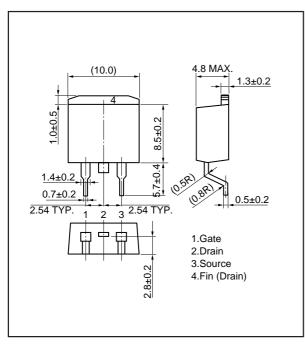
1) TO-220AB (MP-25)



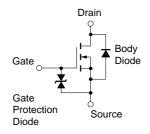
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device. [MEMO]

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